Application/Control No. Applicant(s)/Patent Under Reexamination 10/687,288 YUEH ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Daborah Chacko-Davis 1756 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 430/312 04-2005 US-2005/0074699 Sun et al. Α US-В US-С US-D Ε US-US-F US-G US-Н US-1 US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W Х

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